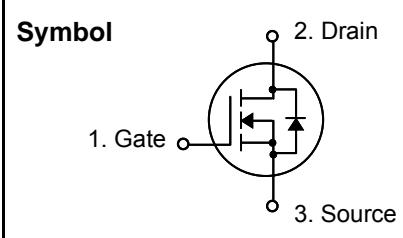


## **Logic N-Channel MOSFET**

### **Features**

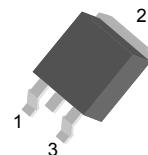
- Low  $R_{DS(on)}$  (0.0085Ω) @ $V_{GS}=10V$
- Low Gate Charge (Typical 39nC)
- Low  $C_{RSS}$  (Typical 185pF)
- Improved dv/dt Capability
- 100% Avalanche Tested
- Maximum Junction Temperature Range (175°C)



### **General Description**

This Power MOSFET is produced using SemiWell's advanced planar stripe, DMOS technology. This latest technology has been especially designed to minimize on-state resistance, have a low gate charge with superior switching performance, and rugged avalanche characteristics. This Power MOSFET is well suited for synchronous DC-DC Converters and Power Management in portable and battery operated products.

**D<sup>2</sup>-PACK (TO-263)**



### **Absolute Maximum Ratings**

Symbol	Parameter	Value	Units
$V_{DSS}$	Drain to Source Voltage	30	V
$I_D$	Continuous Drain Current(@ $T_C = 25^\circ C$ )	95	A
	Continuous Drain Current(@ $T_C = 100^\circ C$ )	67.3	A
$I_{DM}$	Drain Current Pulsed	380	A
$V_{GS}$	Gate to Source Voltage	$\pm 20$	V
$E_{AS}$	Single Pulsed Avalanche Energy	450	mJ
$dv/dt$	Peak Diode Recovery $dv/dt$	7.0	V/ns
$P_D$	Total Power Dissipation(@ $T_A = 25^\circ C$ ) *	3.75	W
	Total Power Dissipation(@ $T_C = 25^\circ C$ )	150	W
	Derating Factor above 25 °C	1.0	W/°C
$T_{STG}, T_J$	Operating Junction Temperature & Storage Temperature	- 55 ~ 175	°C
$T_L$	Maximum Lead Temperature for soldering purpose, 1/8 from Case for 5 seconds.	300	°C

### **Thermal Characteristics**

Symbol	Parameter	Value			Units
		Min.	Typ.	Max.	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	-	-	1.0	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *	-	-	40	°C/W
$R_{\theta CA}$	Thermal Resistance, Case-to-Ambient	-	-	62.5	°C/W

\* When mounted on the minimum pad size recommended (PCB Mount)

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## Electrical Characteristics ( $T_C = 25^\circ\text{C}$ unless otherwise noted )

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
<b>Off Characteristics</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}} = 0\text{V}$ , $I_D = 250\mu\text{A}$	30	-	-	V
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Breakdown Voltage Temperature coefficient	$I_D = 250\mu\text{A}$ , referenced to $25^\circ\text{C}$	-	0.023	-	$\text{V}/^\circ\text{C}$
$I_{\text{DSS}}$	Drain-Source Leakage Current	$V_{\text{DS}} = 30\text{V}$ , $V_{\text{GS}} = 0\text{V}$	-	-	1	$\mu\text{A}$
		$V_{\text{DS}} = 24\text{V}$ , $T_C = 150^\circ\text{C}$	-	-	10	$\mu\text{A}$
$I_{\text{GSS}}$	Gate-Source Leakage, Forward	$V_{\text{GS}} = 20\text{V}$ , $V_{\text{DS}} = 0\text{V}$	-	-	100	nA
	Gate-Source Leakage, Reverse	$V_{\text{GS}} = -20\text{V}$ , $V_{\text{DS}} = 0\text{V}$	-	-	-100	nA
<b>On Characteristics</b>						
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}$ , $I_D = 250\mu\text{A}$	1.0	-	3.0	V
$R_{\text{DS}(\text{ON})}$	Static Drain-Source On-state Resistance	$V_{\text{GS}} = 10\text{V}$ , $I_D = 47.5\text{A}$ $V_{\text{GS}} = 5\text{V}$ , $I_D = 47.5\text{A}$	- -	0.0065 0.0085	0.0085 0.0115	$\Omega$
<b>Dynamic Characteristics</b>						
$C_{\text{iss}}$	Input Capacitance	$V_{\text{GS}} = 0\text{V}$ , $V_{\text{DS}} = 25\text{V}$ , $f = 1\text{MHz}$	-	1015	1320	$\text{pF}$
$C_{\text{oss}}$	Output Capacitance		-	845	1110	
$C_{\text{rss}}$	Reverse Transfer Capacitance		-	185	240	
<b>Dynamic Characteristics</b>						
$t_{\text{d}(\text{on})}$	Turn-on Delay Time	$V_{\text{DD}} = 15\text{V}$ , $I_D = 95\text{A}$ , $R_G = 50\Omega$ <b>* see fig. 13.</b> (Note 4, 5)	-	45	100	$\text{ns}$
$t_r$	Rise Time		-	165	340	
$t_{\text{d}(\text{off})}$	Turn-off Delay Time		-	70	150	
$t_f$	Fall Time		-	140	290	
$Q_g$	Total Gate Charge	$V_{\text{DS}} = 24\text{V}$ , $V_{\text{GS}} = 5\text{V}$ , $I_D = 95\text{A}$ <b>* see fig. 12.</b> (Note 4, 5)	-	39	51	$\text{nC}$
$Q_{\text{gs}}$	Gate-Source Charge		-	13	-	
$Q_{\text{gd}}$	Gate-Drain Charge(Miller Charge)		-	18	-	

## Source-Drain Diode Ratings and Characteristics

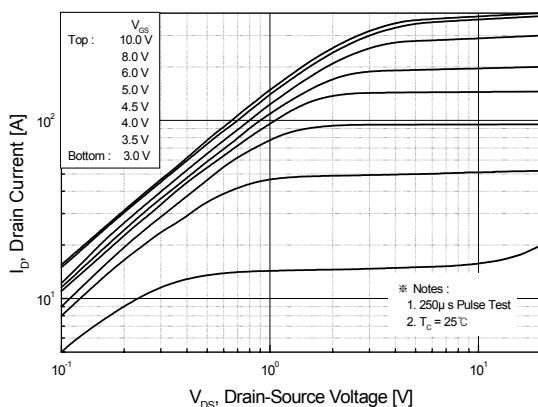
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit.
$I_S$	Continuous Source Current	Integral Reverse p-n Junction Diode in the MOSFET	-	-	95	A
$I_{\text{SM}}$	Pulsed source Current		-	-	380	
$V_{\text{SD}}$	Diode Forward Voltage	$I_S = 95\text{A}$ , $V_{\text{GS}} = 0\text{V}$	-	-	1.5	V
$t_{\text{rr}}$	Reverse Recovery Time	$I_S = 95\text{A}$ , $V_{\text{GS}} = 0\text{V}$ , $dI_F/dt = 100\text{A/us}$	-	55	-	$\text{ns}$
$Q_{\text{rr}}$	Reverse Recovery Charge		-	65	-	

### \* NOTES

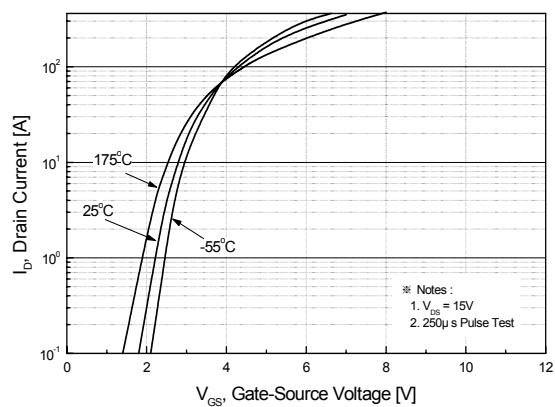
1. Repeatability rating : pulse width limited by junction temperature
2.  $L = 50 \mu\text{H}$ ,  $I_{AS} = 95\text{A}$ ,  $V_{DD} = 15\text{V}$ ,  $R_G = 0\Omega$ , Starting  $T_J = 25^\circ\text{C}$
3.  $ISD \leq 95\text{A}$ ,  $dI/dt \leq 300\text{A/us}$ ,  $V_{DD} \leq \text{BV}_{\text{DSS}}$ . Starting  $T_J = 25^\circ\text{C}$
4. Pulse Test : Pulse Width  $\leq 300\text{us}$ , Duty Cycle  $\leq 2\%$
5. Essentially independent of operating temperature.
6. Continuous Drain current calculated by maximum junction temperature ; limited by package

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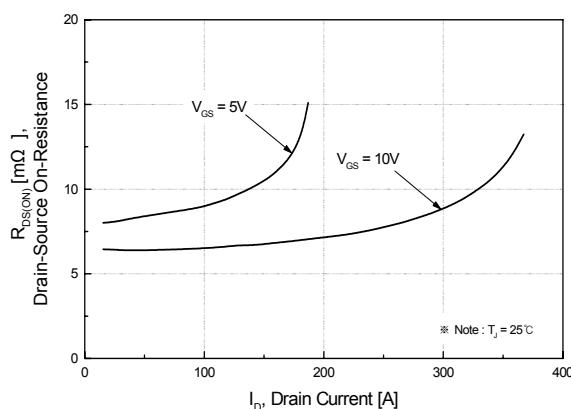
**Fig 1. On-State Characteristics**



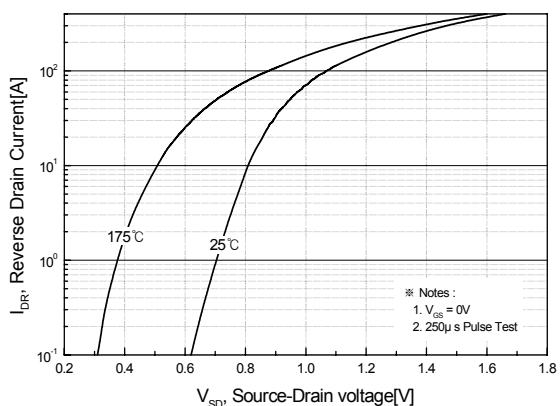
**Fig 2. Transfer Characteristics**



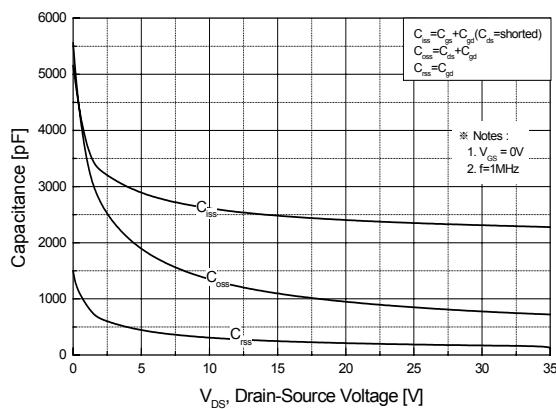
**Fig 3. On Resistance Variation vs. Drain Current and Gate Voltage**



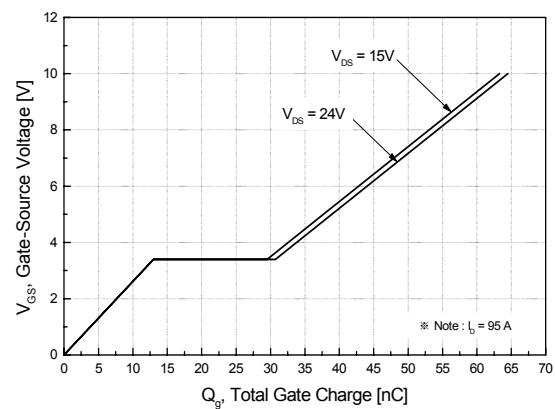
**Fig 4. On State Current vs. Allowable Case Temperature**



**Fig 5. Capacitance Characteristics**

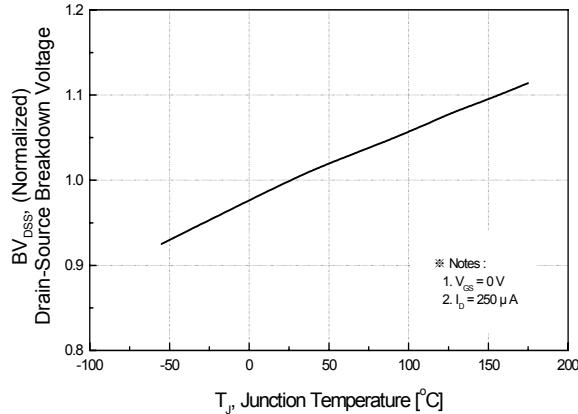


**Fig 6. Gate Charge Characteristics**

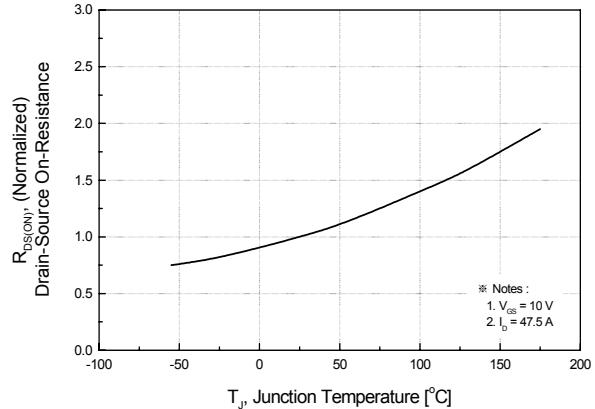


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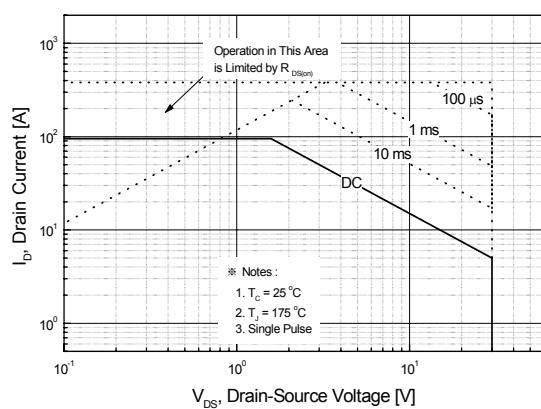
**Fig 7. Breakdown Voltage Variation vs. Junction Temperature**



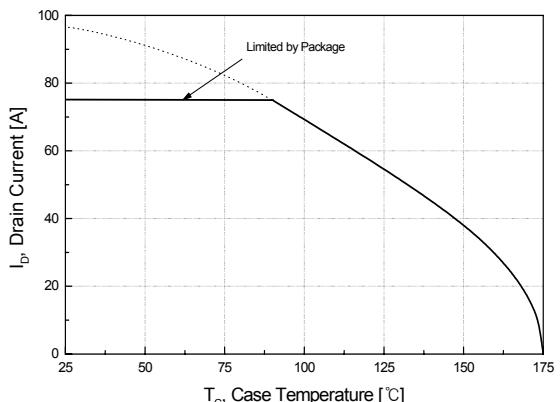
**Fig 8. On-Resistance Variation vs. Junction Temperature**



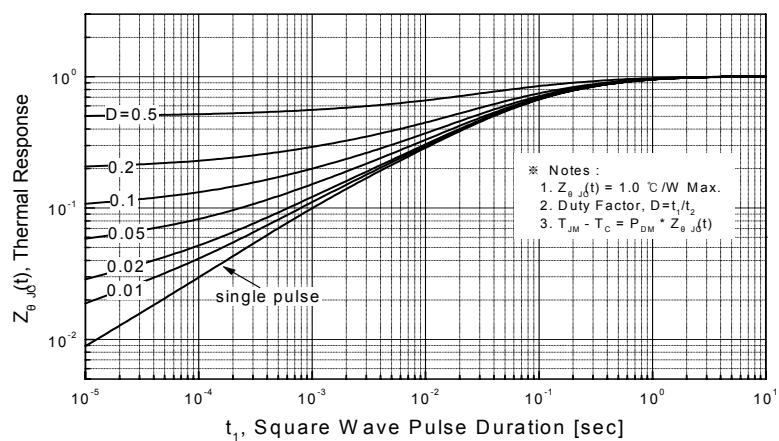
**Fig 9. Maximum Safe Operating Area**

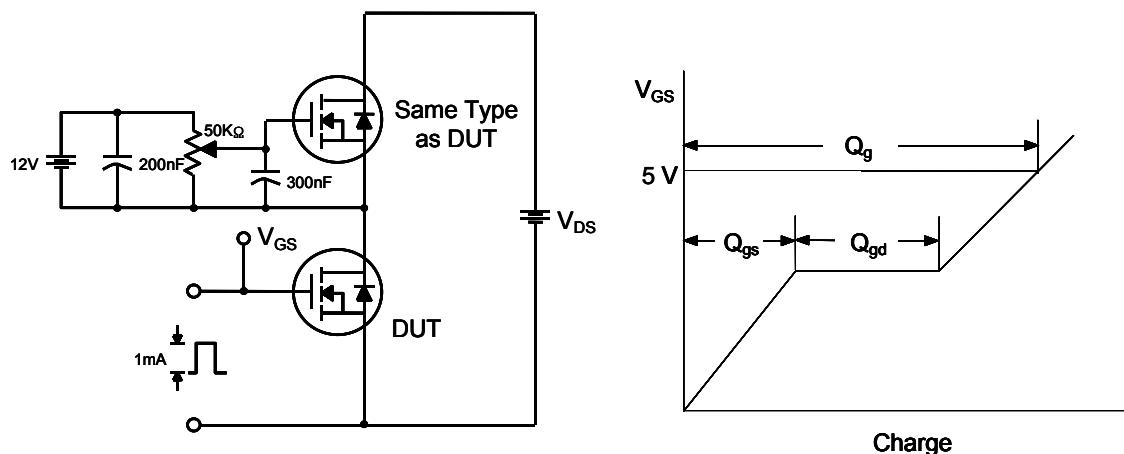
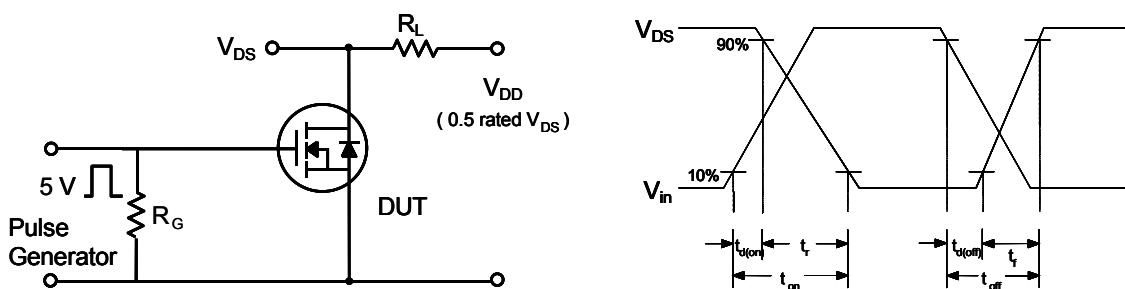
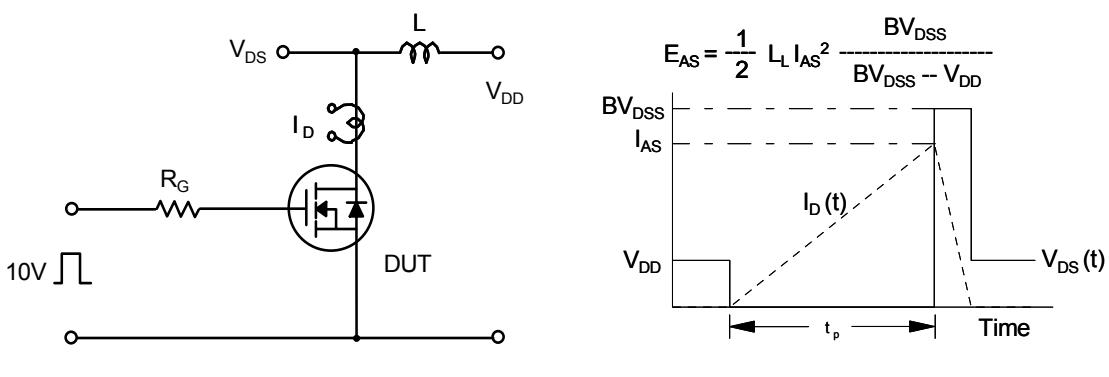


**Fig 10. Maximum Drain Current vs. Case Temperature**



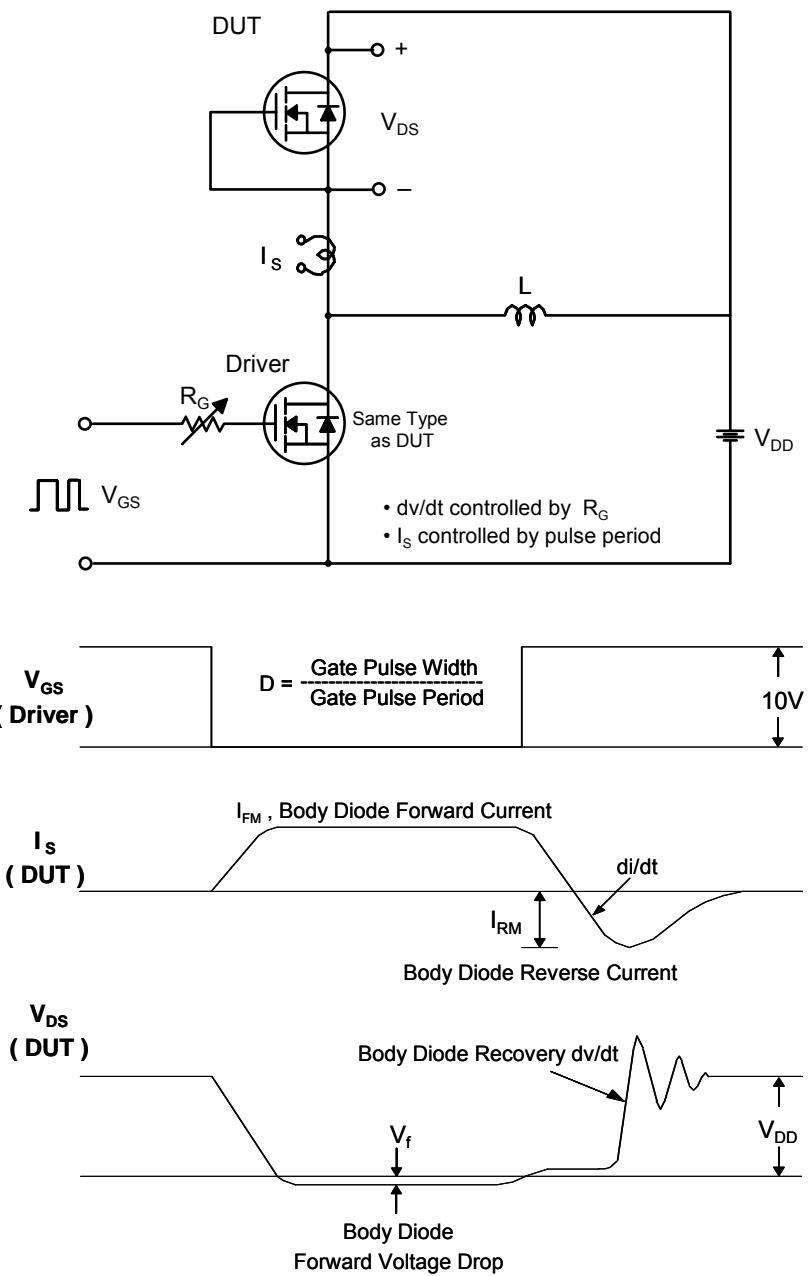
**Fig 11. Transient Thermal Response Curve**



**SFB95N03L****Fig. 12. Gate Charge Test Circuit & Waveforms****Fig 13. Switching Time Test Circuit & Waveforms****Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms**

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**Fig. 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms**



**SFB95N03L****TO-263(D<sup>2</sup>-PAK) Package Dimension**

Dim.	mm			Inch		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	9.8	10	10.2	0.386	0.394	0.402
B	7.9	8	8.1	0.311	0.315	0.319
C	11.2	11.8	12.4	0.441	0.465	0.488
D	4.3	4.5	4.7	0.169	0.177	0.185
E	1.25	1.3	1.4	0.049	0.051	0.055
F	1.0	1.2	1.4	0.039	0.047	0.055
G		2.54			0.1	
H		2.54			0.1	
I	2.24	2.54	2.84	0.088	0.1	0.112
J	2.2	2.4	2.6	0.087	0.094	0.102
K	0.45	0.5	0.6	0.018	0.02	0.024
L	0.7	0.8	0.9	0.028	0.031	0.035
$\phi$		1.57			0.06	

